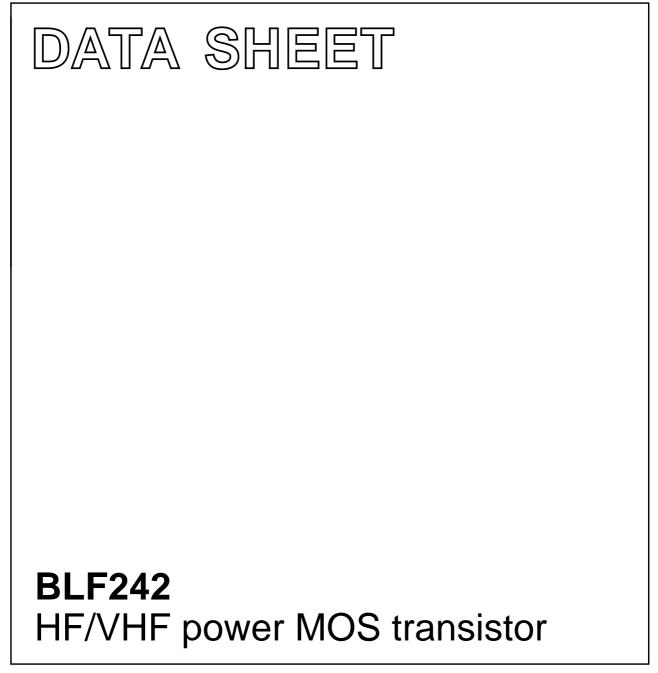
DISCRETE SEMICONDUCTORS



Product specification

September 1992



HILIPS

### **BLF242**

#### FEATURES

- High power gain
- Low noise
- Easy power control
- Good thermal stability
- Withstands full load mismatch
- Gold metallization ensures excellent reliability.

#### DESCRIPTION

Silicon N-channel enhancement mode vertical D-MOS transistor designed for professional transmitter applications in the HF/VHF frequency range.

The transistor is encapsulated in a 4-lead, SOT123 flange envelope, with a ceramic cap. All leads are isolated from the flange.

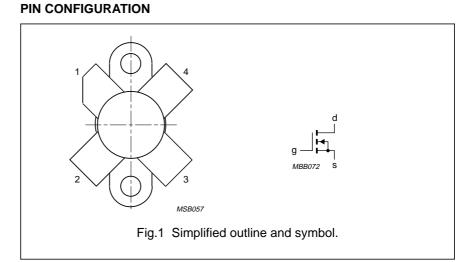
#### **PINNING - SOT123**

PIN	DESCRIPTION
1	drain
2	source
3	gate
4	source

#### QUICK REFERENCE DATA

RF performance at T<sub>h</sub> = 25 °C in a common source test circuit.

MODE OF OPERATION	f	V <sub>DS</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>D</sub>
	(MHz)	(V)	(W)	(dB)	(%)
CW, class-B	175	28	5	> 13 typ. 16	> 50 typ. 60



#### CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static charge during transport and handling.

#### WARNING

Product and environmental safety	- toxic materials
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This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

### **BLF242**

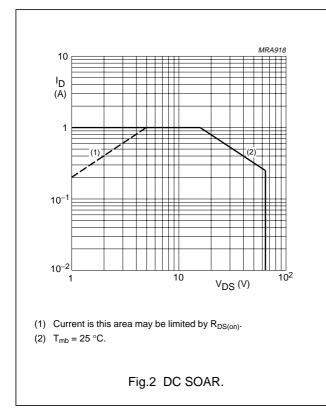
#### LIMITING VALUES

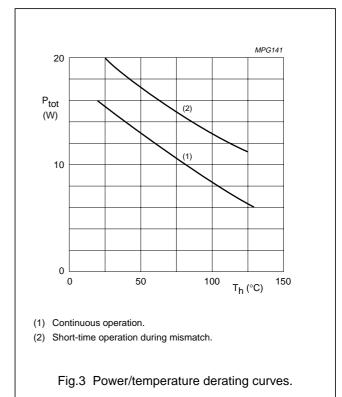
In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage		_	65	V
±V <sub>GS</sub>	gate-source voltage		-	20	V
I <sub>D</sub>	DC drain current		-	1	А
P <sub>tot</sub>	total power dissipation	up to T <sub>mb</sub> = 25 °C	_	16	W
T <sub>stg</sub>	storage temperature		-65	150	°C
Tj	junction temperature		—	200	°C

#### THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	THERMAL RESISTANCE
R <sub>th j-mb</sub>	thermal resistance from junction to mounting base	$T_{mb} = 25 \ ^{\circ}C; \ P_{tot} = 16 \ W$	11 K/W
R <sub>th mb-h</sub>	thermal resistance from mounting base to heatsink	$T_{mb} = 25 \ ^{\circ}C; \ P_{tot} = 16 \ W$	0.3 K/W



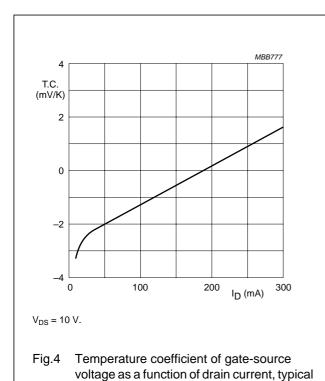


### **BLF242**

#### CHARACTERISTICS

 $T_j = 25 \ ^{\circ}C$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	V <sub>GS</sub> = 0; I <sub>D</sub> = 0.1 mA	65	-	-	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V	-	-	10	μA
I <sub>GSS</sub>	gate-source leakage current	$\pm V_{GS} = 20 \text{ V}; \text{ V}_{DS} = 0$	-	-	1	μA
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 3 mA; V <sub>DS</sub> = 10 V	2	-	4.5	V
9 <sub>fs</sub>	forward transconductance	I <sub>D</sub> = 0.3 A; V <sub>DS</sub> = 10 V	0.16	0.24	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	I <sub>D</sub> = 0.3 A; V <sub>GS</sub> = 1 V	-	3.3	5	Ω
I <sub>DSX</sub>	on-state drain current	$V_{GS} = 10 \text{ V}; V_{GS} = 10 \text{ V}$	-	1.2	-	А
C <sub>is</sub>	input capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	-	13	-	pF
C <sub>os</sub>	output capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	-	9.4	-	pF
C <sub>rs</sub>	feedback capacitance	$V_{GS} = 0; V_{DS} = 28 V; f = 1 MHz$	-	1.7	-	pF



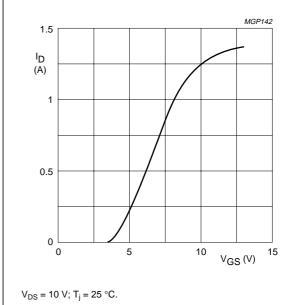
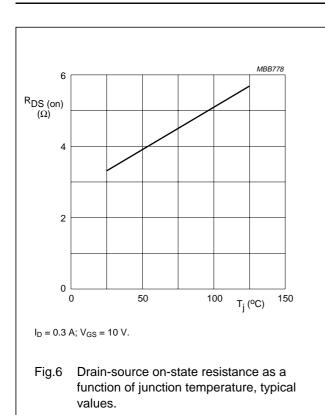
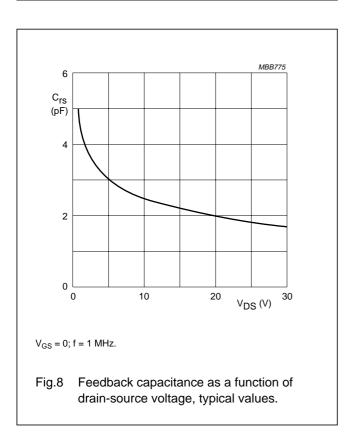


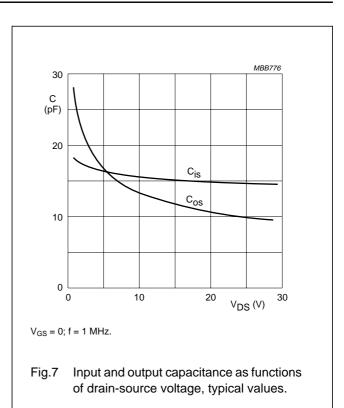
Fig.5 Drain current as a function of gate-source voltage, typical values.

values.

# **BLF242**







### BLF242

#### APPLICATION INFORMATION FOR CLASS-B OPERATION

 $T_{h}$  = 25 °C;  $R_{th\ mb\mathchar`left h}$  = 0.3 K/W; unless otherwise specified.

RF performance in CW operation in a common source class-B test circuit.

MODE OF OPERATION	f	V <sub>DS</sub>	I <sub>DQ</sub>	P <sub>L</sub>	G <sub>P</sub>	η <sub>D</sub>	R <sub>GS</sub>
	(MHz)	(V)	(mA)	(W)	(dB)	(%)	(Ω)
CW, class-B	175	28	10	5	> 13 typ. 16	> 50 typ. 60	47

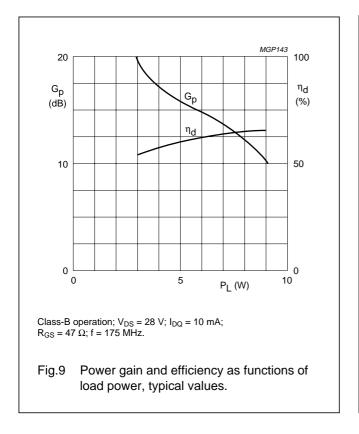
#### **Ruggedness in class-B operation**

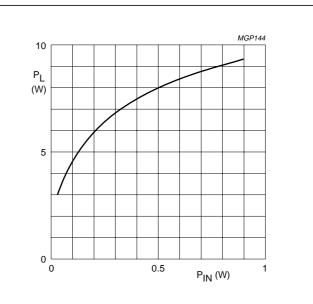
The BLF242 is capable of withstanding a load mismatch corresponding to VSWR = 50 through all phases under the following conditions:

 $V_{DS}$  = 28 V; f =175 MHz at rated output power.

#### Noise figure (see Fig.11)

 $\label{eq:VDS} \begin{array}{l} \mathsf{V}_{DS} = 28 \; \mathsf{V}; \; \mathsf{I}_{D} = 0.2 \; \mathsf{A}; \; \mathsf{f} = 175 \; \mathsf{MHz}; \\ \mathsf{R}_{GS} = 47 \; \Omega; \; \mathsf{T}_{h} = 25 \; ^{\circ}\mathsf{C}. \; \mathsf{Input} \; \mathsf{and} \\ \mathsf{output} \; \mathsf{power} \; \mathsf{matched} \; \mathsf{for} \; \mathsf{P}_{\mathsf{L}} = 5 \; \mathsf{W}; \\ \mathsf{F} = \mathsf{typ}. \; \mathsf{5.5} \; \mathsf{dB}. \end{array}$ 

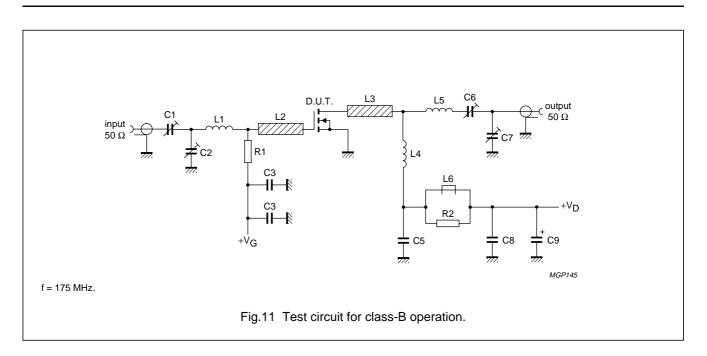




Class-B operation; V\_{DS} = 28 V; I\_{DQ} = 10 mA; R\_{GS} = 47 \ \Omega; f = 175 MHz.

Fig.10 Load power as a function of input power, typical values.

### **BLF242**



#### List of components (class-B test circuit)

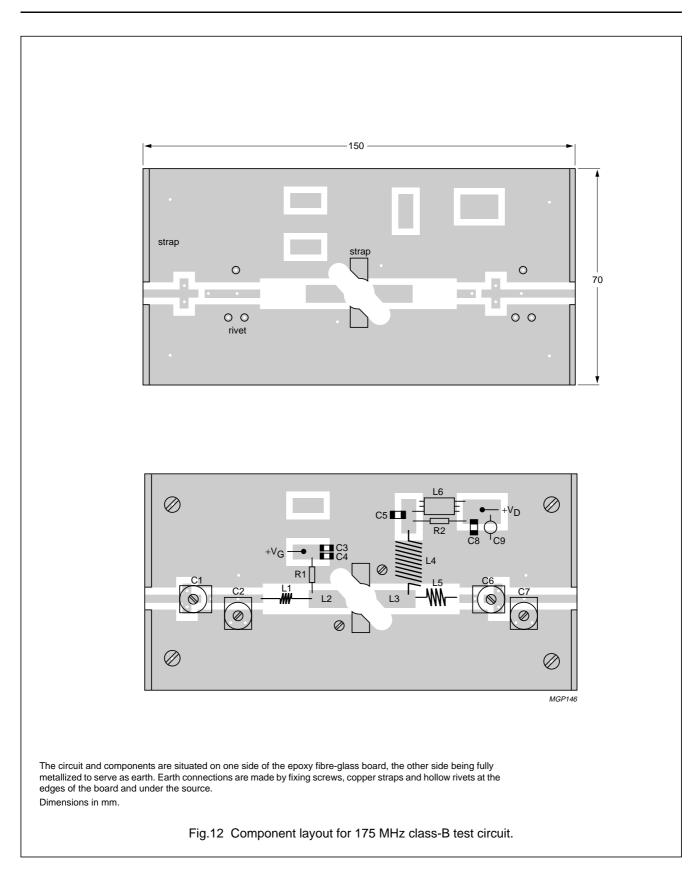
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C2, C7	film dielectric trimmer	4 to 40 pF		2222 809 08002
C3	multilayer ceramic chip capacitor (note 1)	100 pF		
C4, C8	ceramic chip capacitor	100 nF		2222 852 47104
C6	film dielectric trimmer	5 to 60 pF		2222 809 08003
C9	electrolytic capacitor	2.2 μF, 40 V		
L1	5 turns enamelled 0.7 mm copper wire	53 nH	length 5.4 mm int. dia. 3 mm leads $2 \times 5$ mm	
L2, L3	stripline (note 2)	30 Ω	10 × 6 mm	
L4	11 turns enamelled 1 mm copper wire	500 nH	length 15.5 mm int. dia. 8 mm leads $2 \times 5$ mm	
L5	5 turns enamelled 1 mm copper wire	79 nH	length 9.1 mm int. dia. 5 mm leads $2 \times 5$ mm	
L6	grade 3B Ferroxcube RF choke			4312 020 36640
R1	0.5 W metal film resistor	47 Ω		
R2	0.5 W metal film resistor	10 Ω		

#### Notes

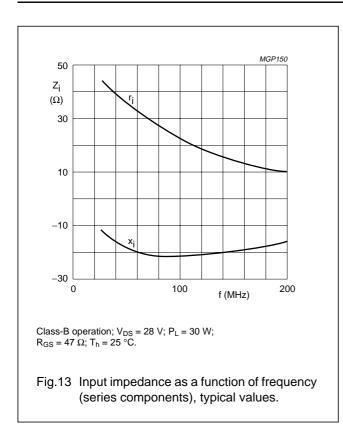
1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.

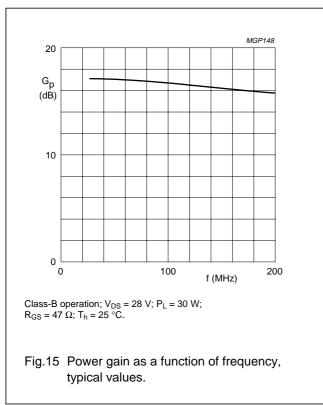
2. The striplines are on a double copper-clad printed circuit board, with epoxy fibre-glass dielectric ( $\epsilon_r = 4.5$ ), thickness  $1/_{16}$  inch.

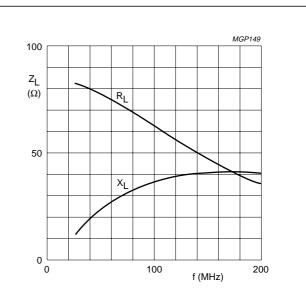
### BLF242



# BLF242







Class-B operation; V\_{DS} = 28 V; P\_L = 30 W; R\_{GS} = 47 \ \Omega; T\_h = 25 \ ^\circ C.

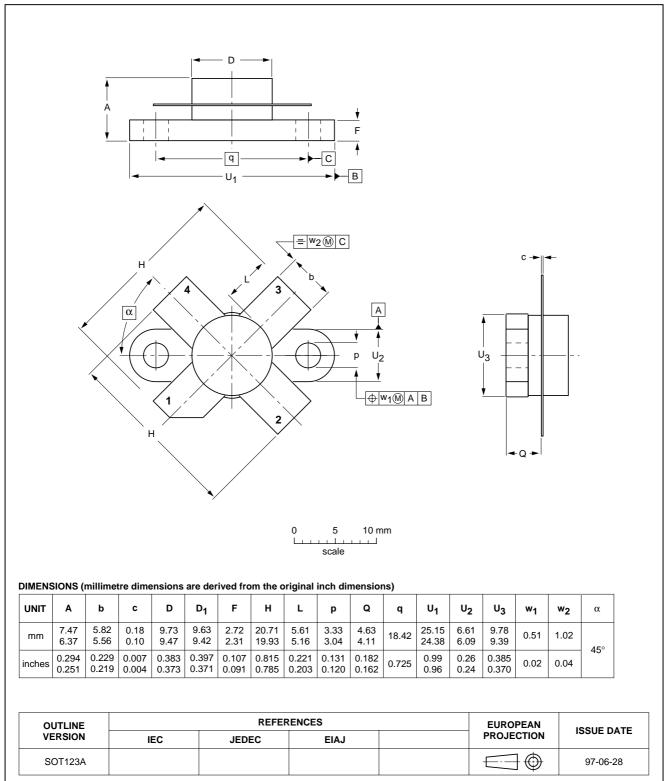
# Fig.14 Load impedance as a function of frequency (series components), typical values.

**BLF242** 

# HF/VHF power MOS transistor

#### PACKAGE OUTLINE

#### Flanged ceramic package; 2 mounting holes; 4 leads



SOT123A

### Product specification

### **BLF242**

#### DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
more of the limiting values m of the device at these or at a	accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or hay cause permanent damage to the device. These are stress ratings only and operation any other conditions above those given in the Characteristics sections of the specification miting values for extended periods may affect device reliability.

#### Application information

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.